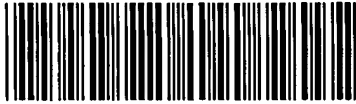


Search Notes

Application/Control No.

10/736,574

Examiner

Sherali Ishrat

Applicant(s)/Patent under
Reexamination

SAKAIDA, HIDEYUKI

Art Unit

2624

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------------------------|------------|----------|
| 382 | 162-167 274- 275 254 | 11/22/2007 | IS |
| 358 | 515-517 | 11/22/2007 | IS |
| | 1.9 | | |
| | 3.26 | | |
| 348 | 223.1- | 11/22/2007 | IS |
| | 226, 2323 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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| SEARCH | USPGPUB | 11/22/2007 | IS |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|------------|------------|------|
| IEEE, EAST | 11/22/2007 | IS |
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